


FORM PTO-1449	Atty. Docket No.: R11.12-0701	Appl. No.: 09/667,297
 <p>LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT</p>	First Named Inventor:	
	Eric R. Lovegren et al.	
	Filing Date	Group Art:
	September 22, 2000	2857

U.S. PATENT DOCUMENTS

Examiner Initial	Document No.	Date	Name	Class	Sub Class	Filing Date If Appropriate
JRW	AA	3,665,466	5/23/72	Hibbard	343	12
JRW	AB	3,812,422	5/21/74	DeCarolus	324	58
JRW	AC	3,995,212	11/30/76	Ross	324	58.50
JRW	AD	4,161,731	7/17/79	Barr	343	14
JRW	AE	5,327,139	7/5/94	Johnson	342	22
JRW	AF	5,438,867	8/8/95	van der Pol	73	290
JRW	AG	5,500,649	3/19/96	Mowrey et al.	342	22
JRW	AH	5,599,449	2/4/97	Gnam et al.	210	495
JRW	AI	5,609,059	3/11/97	McEwan	73	290
JRW	AJ	5,610,611	3/11/97	McEwan	342	89
JRW	AK	5,661,251	8/26/97	Cummings et al.	73	866.5

FOREIGN PATENT DOCUMENTS

		Document No.	Date	Country	Class	Sub Class	Translation Yes No
JRW	AL	EP 0 882 956 A2	12/9/98	EPO - Germany			X
JRW	AM	EP 0 882 957 A2	12/9/98	EPO - Germany			X
	AN						

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

JRW	AO	Matthias Weiß et al., 1997 IEEE MTT-S Digest, "NOVEL METHODS OF MEASURING IMPURITY LEVELS IN LIQUID TANKS," Publ. Date 6/8/97, pp. 1651-1654
JRW	AP	(SPECIAL REPORT) Flow, LEVEL, "Pressure, Radar level technology offers accurate, noncontact measurements," January 1996, I&CS, pp. 27-30
JRW	AQ	KROHNE Technical Data, BM100, BM100EEx, "Reflex-Radar," 12/96, 12 pages

EXAMINER:

Robert R. Woot

DATE CONSIDERED:

02/28/02

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



-3-

Sheet 2 of 2

FORM PTO-1449	Atty. Docket No.: R11.12-0701	Appl. No.: 09/667,297
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT	First Named Inventor:	
	Eric R. Lovegren et al.	
	Filing Date	Group Art:
	September 22, 2000	2857

U.S. PATENT DOCUMENTS

Examiner Initial	Document No.	Date	Name	Class	Sub Class	Filing Date If Appropriate
JRW	AR	5,672,975	9/30/97	Kielb et al.	324	644
JRW	AS	5,835,053	11/10/98	Davis	342	22
JRW	AT	5,898,308	4/27/99	Champion	324	643
	AU					
	AV					
	AW					
	AX					
	AY					
	AZ					
	BA					

RECEIVED
JAN 23 2001
TIC 2800 MAIL ROOM

FOREIGN PATENT DOCUMENTS

	Document No.	Date	Country	Class	Sub Class	Translation Yes No
	BB					
	BC					
	BD					

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

JRW	BE	UCRL-ID-130474, J. Mast, et al., "Micropower Impulse Radar Technology and Applications," April 15, 1998, 14 pages
	BF	"FUNDAMENTALS OF APPLIED ELECTROMAGNETICS" 1999 Edition, Fawwaz T. Ulaby, PRENTICE HALL, Chapter 8, pp. 292-319
	BG	

EXAMINER: <i>[Signature]</i>	DATE CONSIDERED: 02/28/02
------------------------------	---------------------------

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.